

AHCAL Calibration and Temperature Corrections

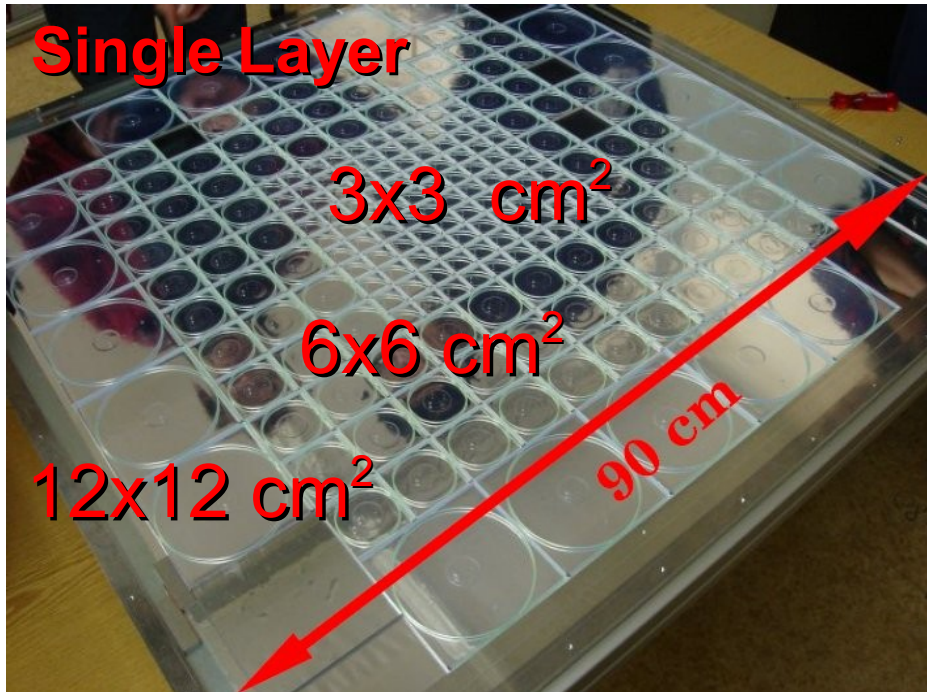
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Outline

- Introduction
- Calibration 2006 / 2007
- Temperature Correction Studies

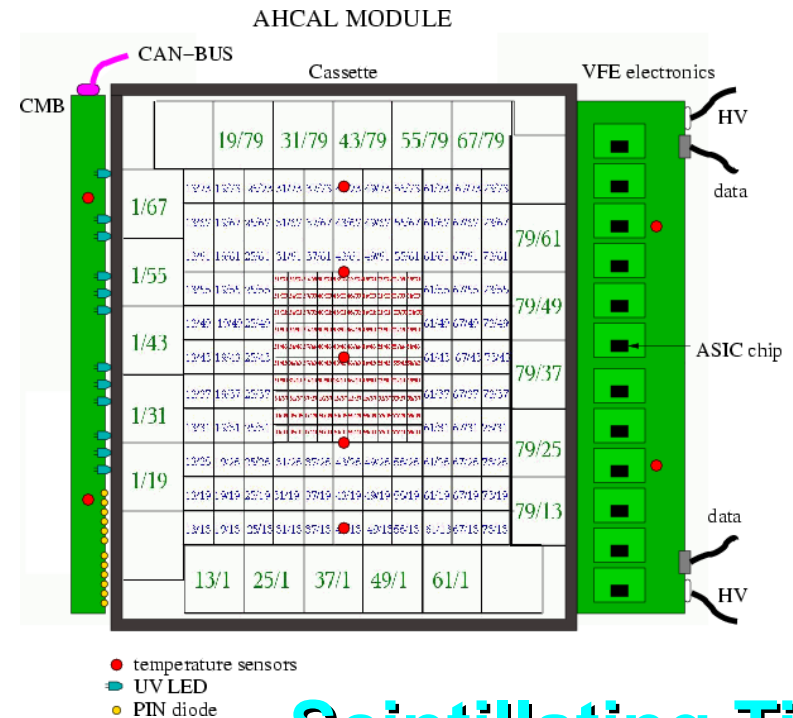
The AHCAL Prototype

- 1m³ steel/scintillator sampling calorimeter
- 38 active layers, 7608 channels

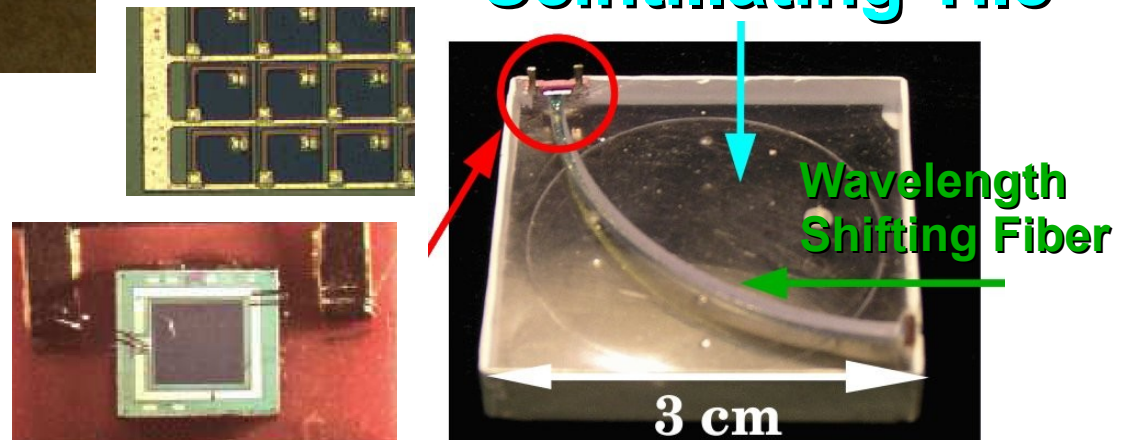


Silicon Photomultiplier (SiPM):

- Developed by MEPhi / PULSAR
- Matrix of independent pixels, each similar to an APD in Geigermode
- Gain: $\sim 10^6$
- Bias-Voltage: ~ 50 V

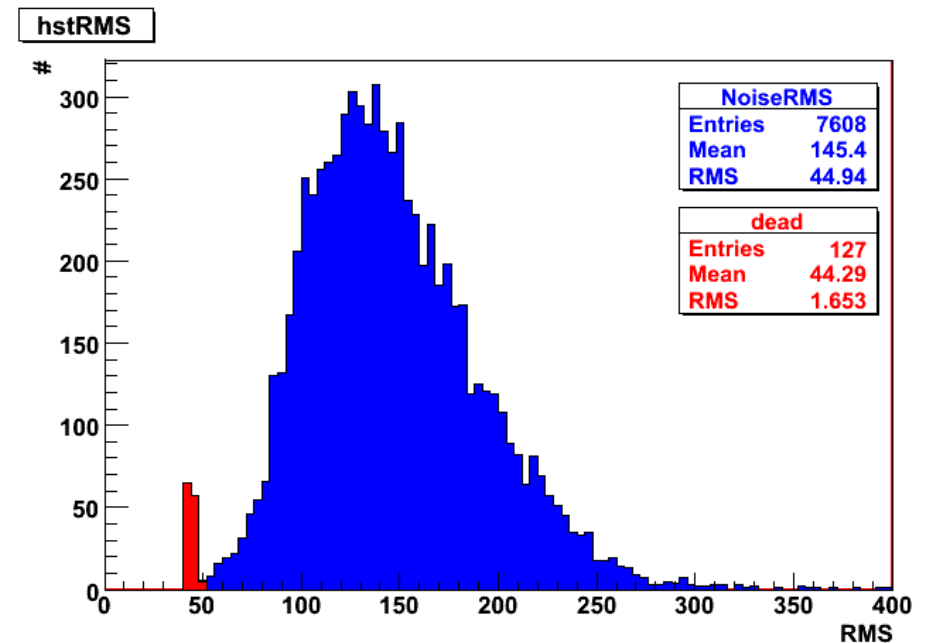
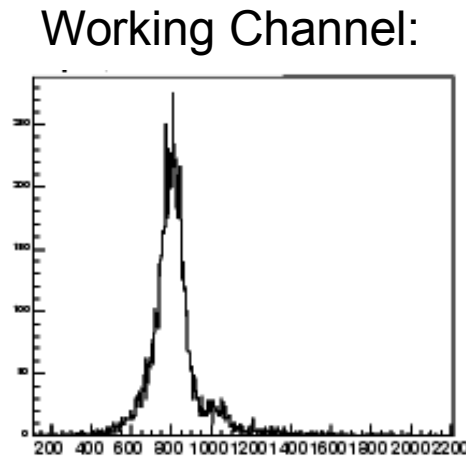
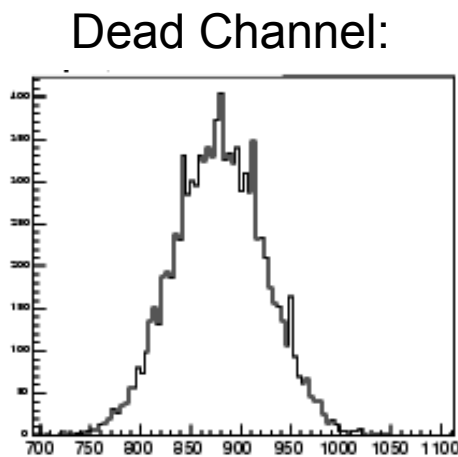


Scintillating Tile

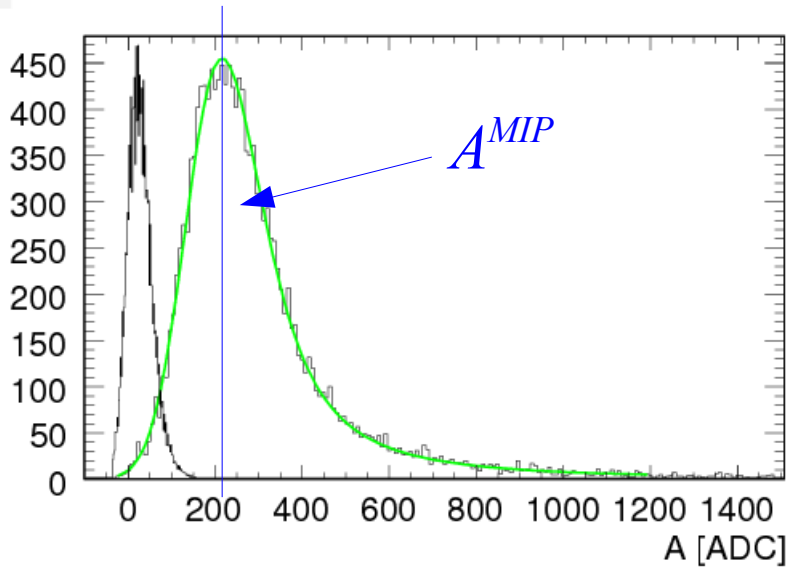


Dead Channels

- Read out channels without beam and LED light.
- Criterion: standard deviation < 50 [ADC ch.] with SiPM bias voltage on.
- Total: 1,7 % dead channels.

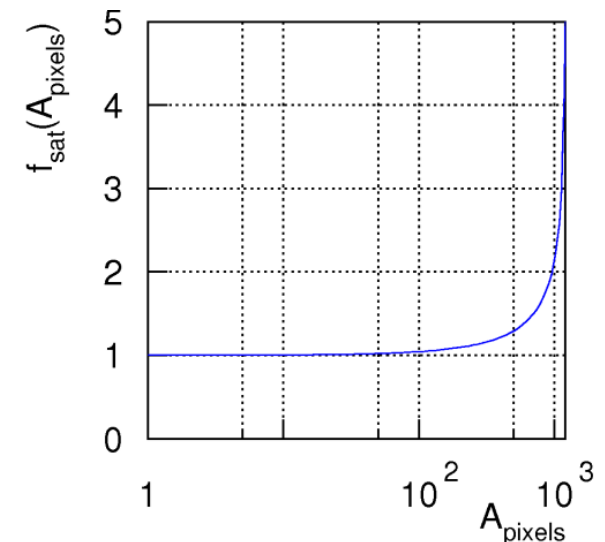
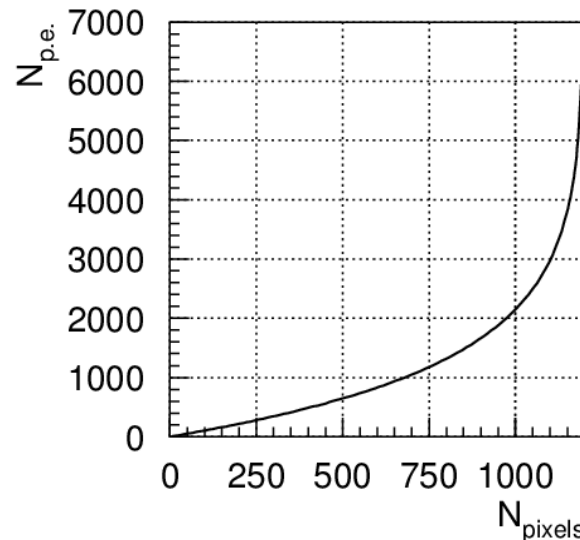
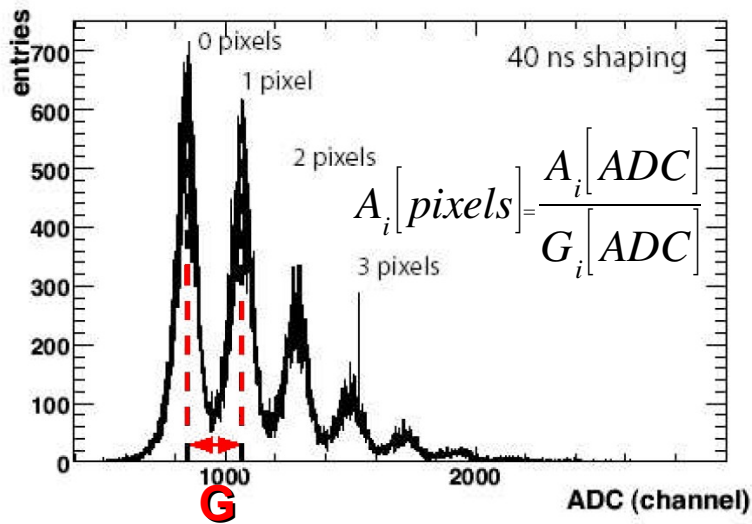


The AHCAL Calibration

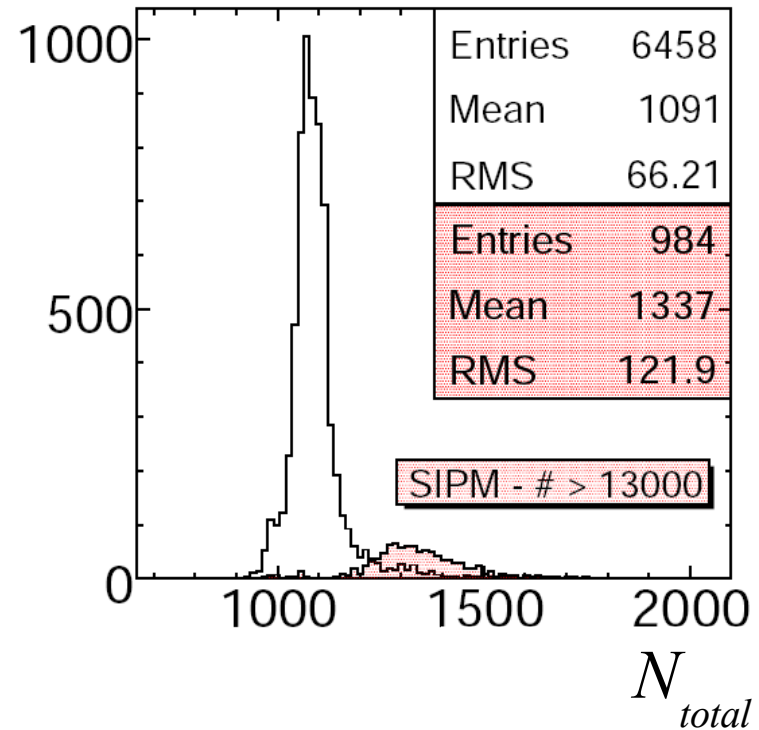
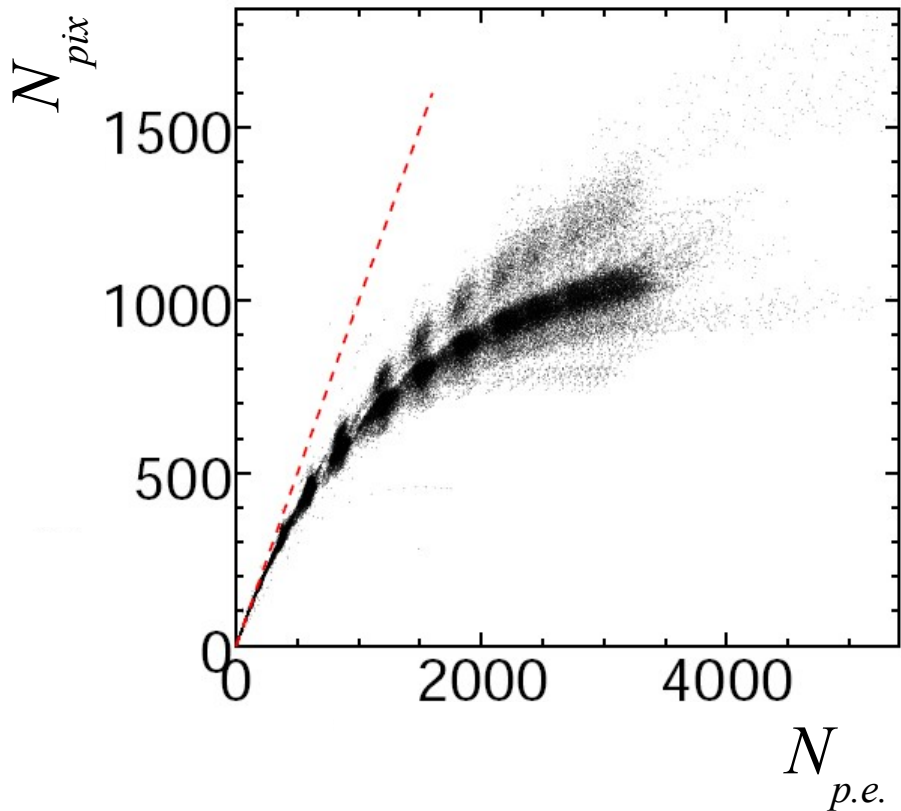


- Calibration via MIP-Signal
- Gain determination from single pixel spectrum
- Correction for SiPM non-linearity:

$$E_i [MIP] = \frac{A_i [ADC]}{A_i^{MIP} [ADC]} \cdot f_{sat}(A_i [pixels])$$



Saturation correction



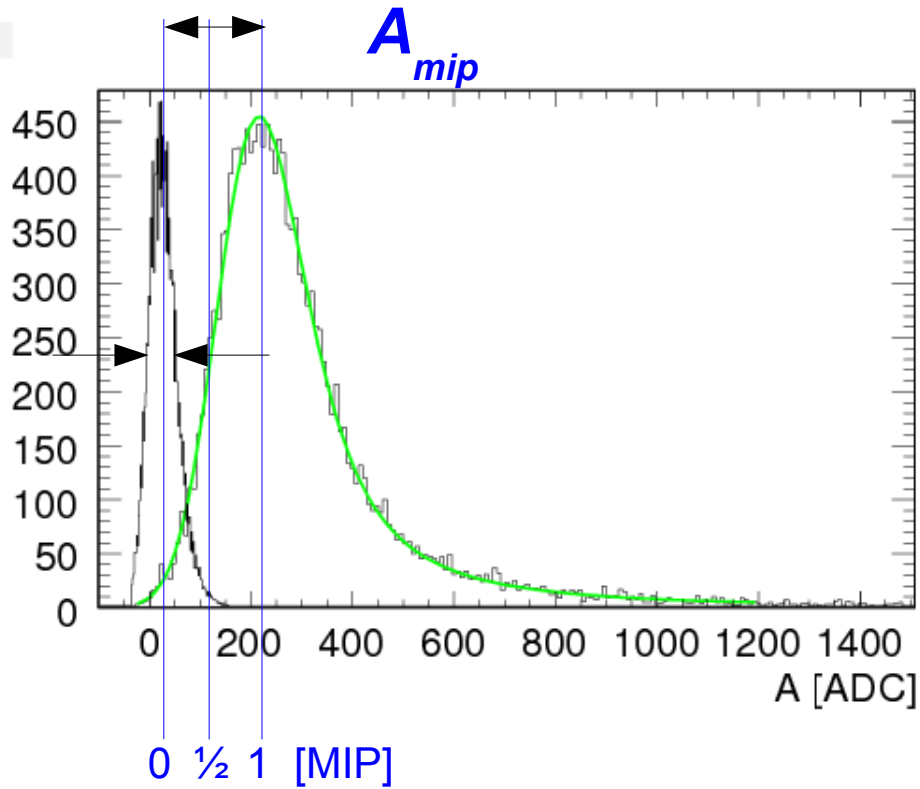
Plots by N. Feege

Simple model:

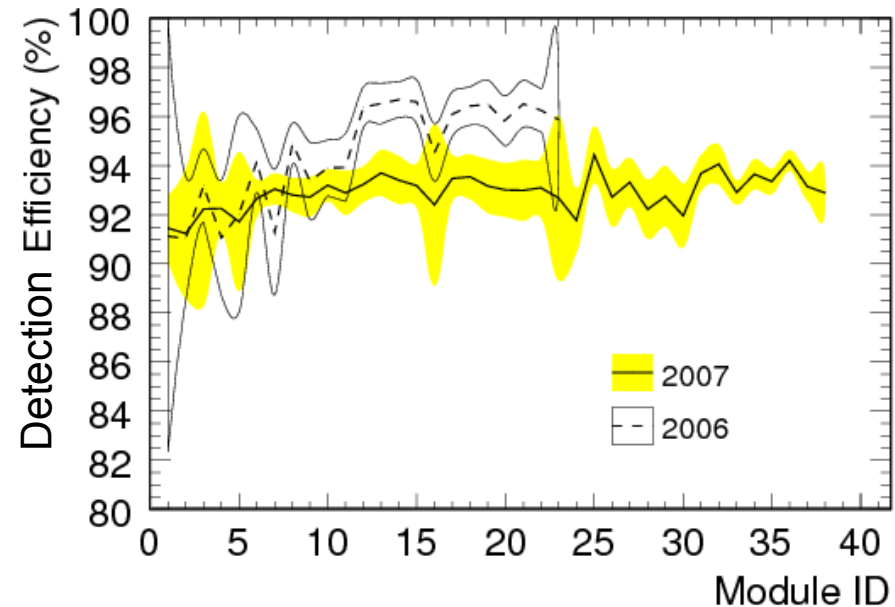
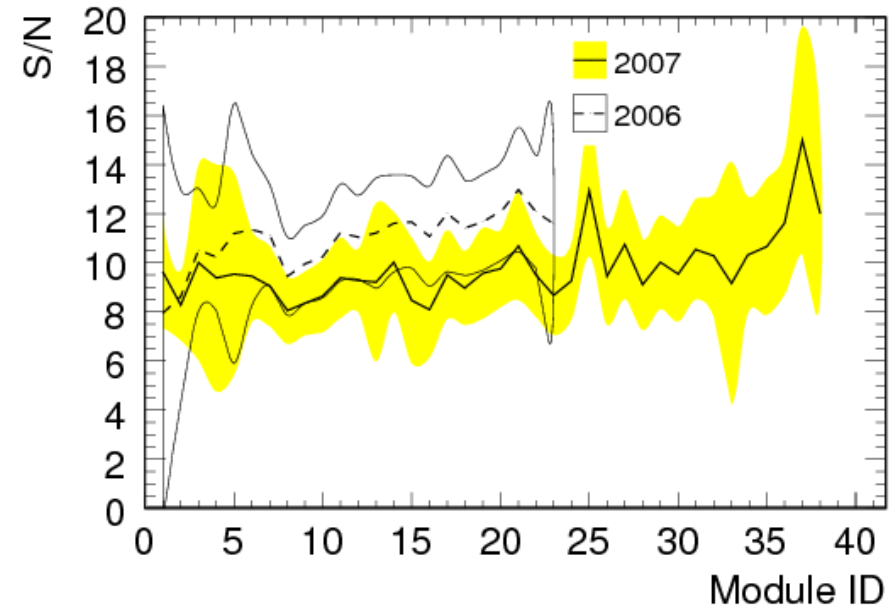
$$N_{pix} = N_{total} \left(1 - \exp \left[\frac{-N_{p.e.}}{N_{total}} \right] \right)$$

- SiPM signal = Σ pixels fired
- N_{total} is finite & recovery time \rightarrow saturation
- Saturation curves provided by ITEP for each SiPM
- under study...

MIP: Detection Efficiency / SNR



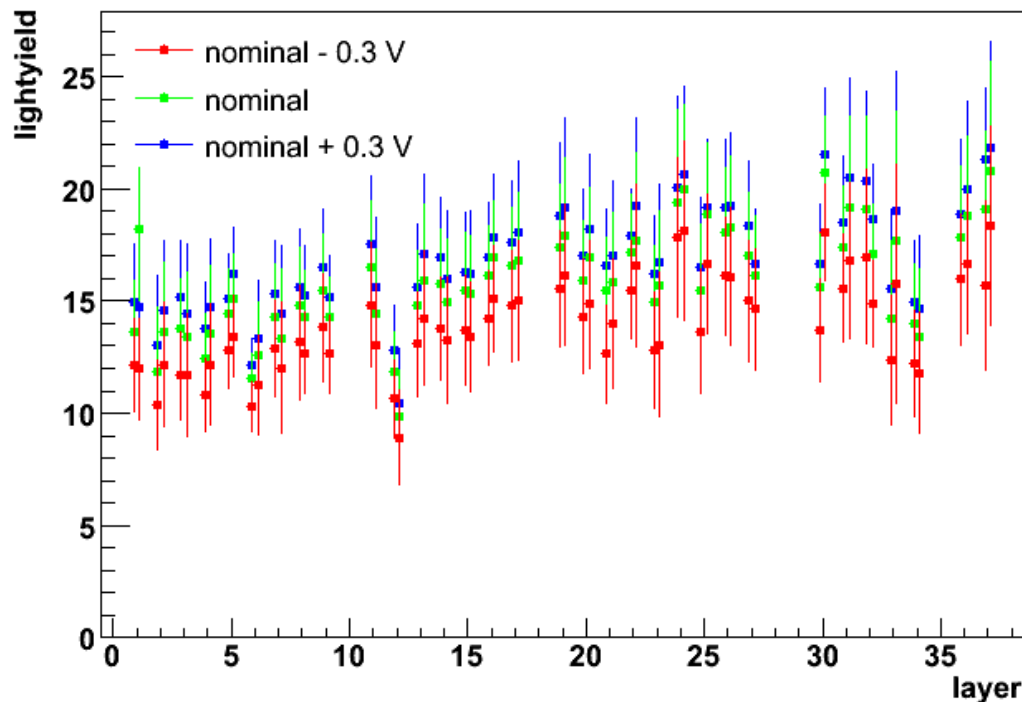
Threshold: 0.5 MIP
Detection efficiency: 93%
SNR: 9



Plots by N. D'Ascenzo

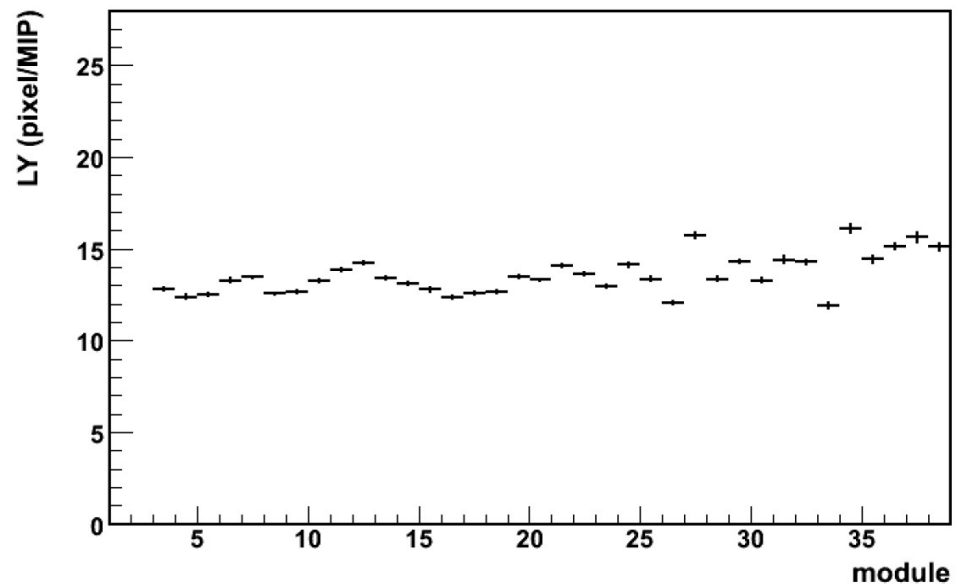
Optimization of the Bias Voltage

- Light Yield: $LY = A^{MIP} [ADC] / G [ADC]$
- Goal: max. MIP SNR & efficiency \rightarrow LY=15 pixels / MIP
- Result: LY=13.5

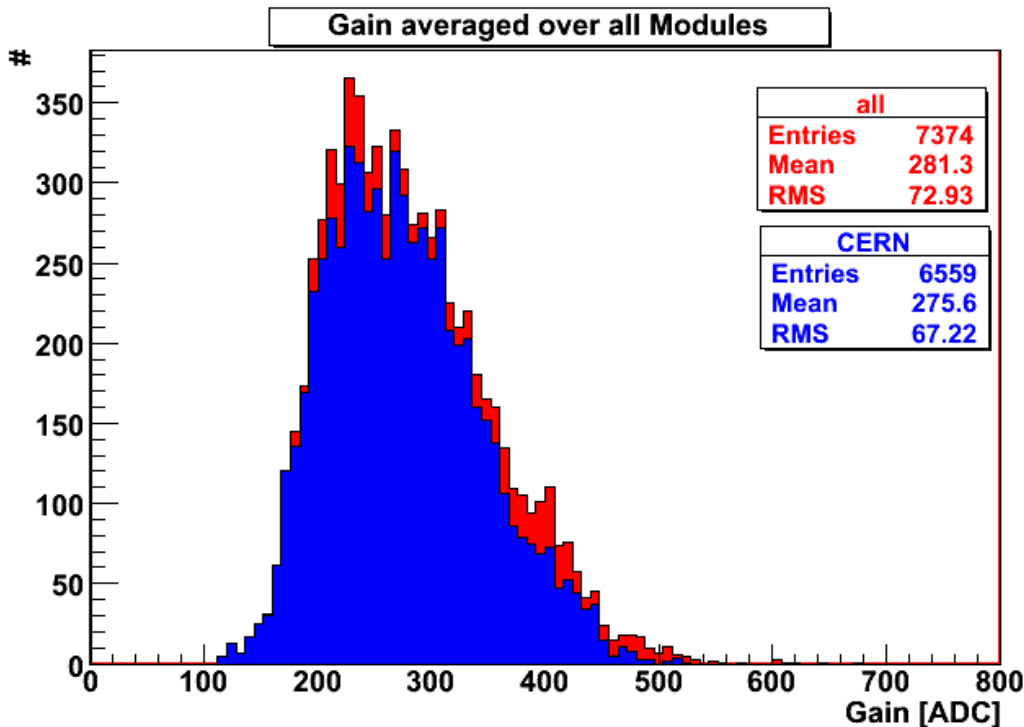
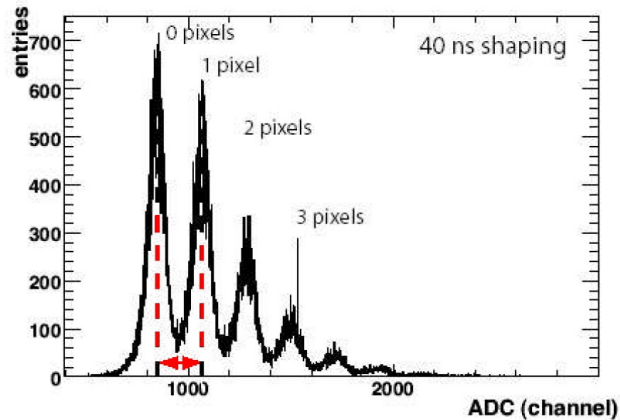


LY per module

Plots by N.Meyer / B.Lutz



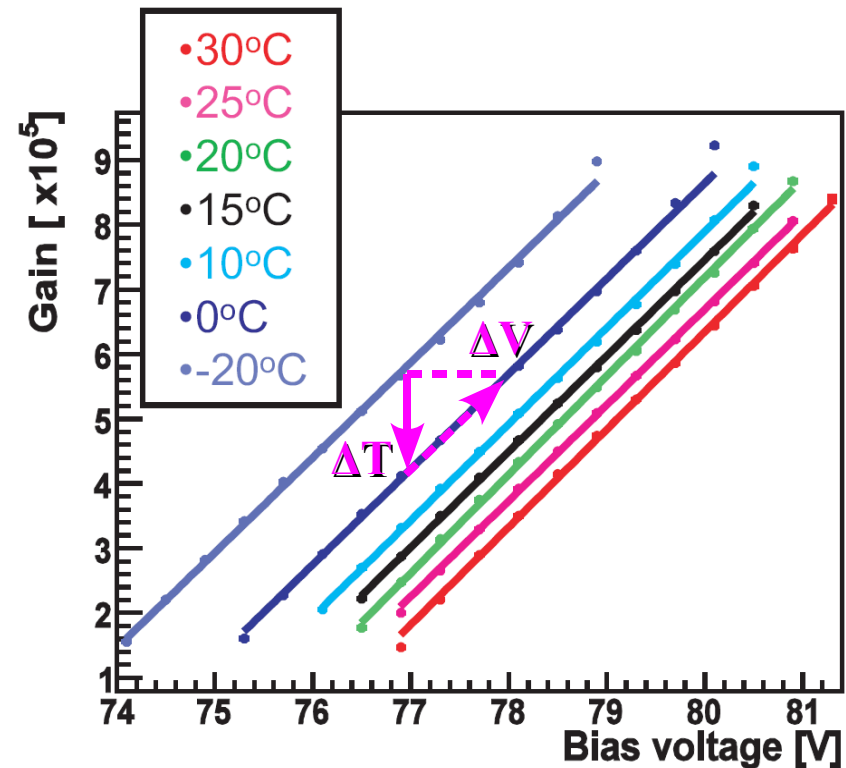
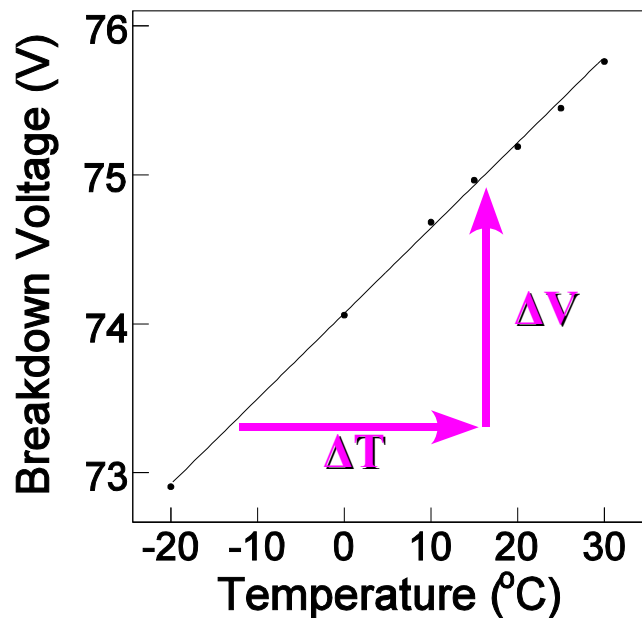
Efficiency of the Gain Calibration



- Single modules were recalibrated at DESY
- Channels with gain calibration available: 96.9%
- 7 LEDs were turned off = 1.7% of the channels
- Stability: $\sigma = 2.6\%$ (without correction of the temperature shifts)

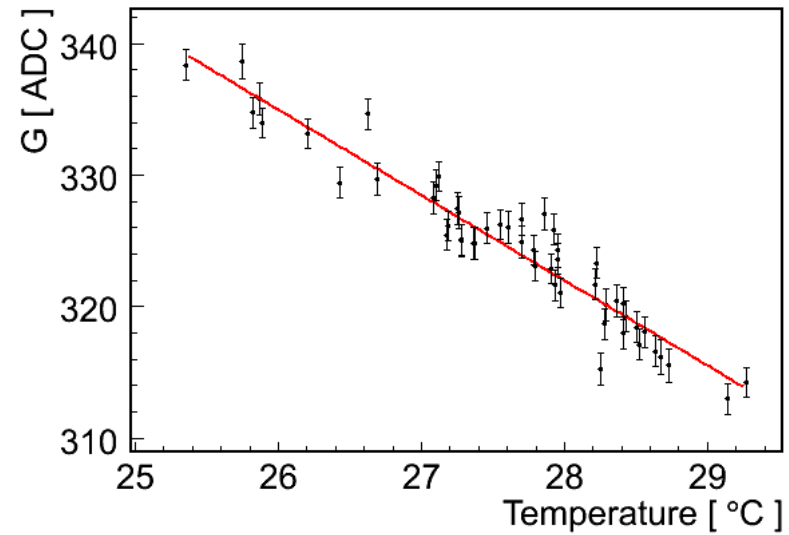
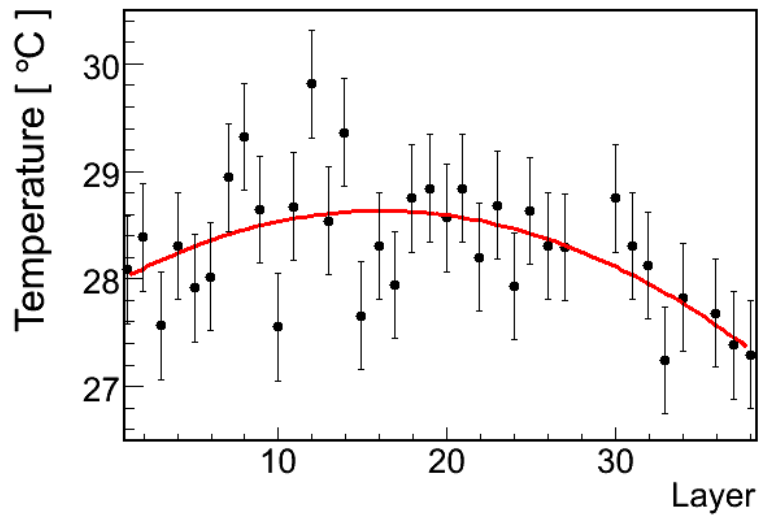
SiPM: Temperature and Voltage

- SiPM signal depends on gain and efficiency: $A \sim G \cdot \varepsilon$
- Both depend on the overvoltage $U = U_{bias} - U_{breakdown}$
- $U_{breakdown}$ is temperature dependent

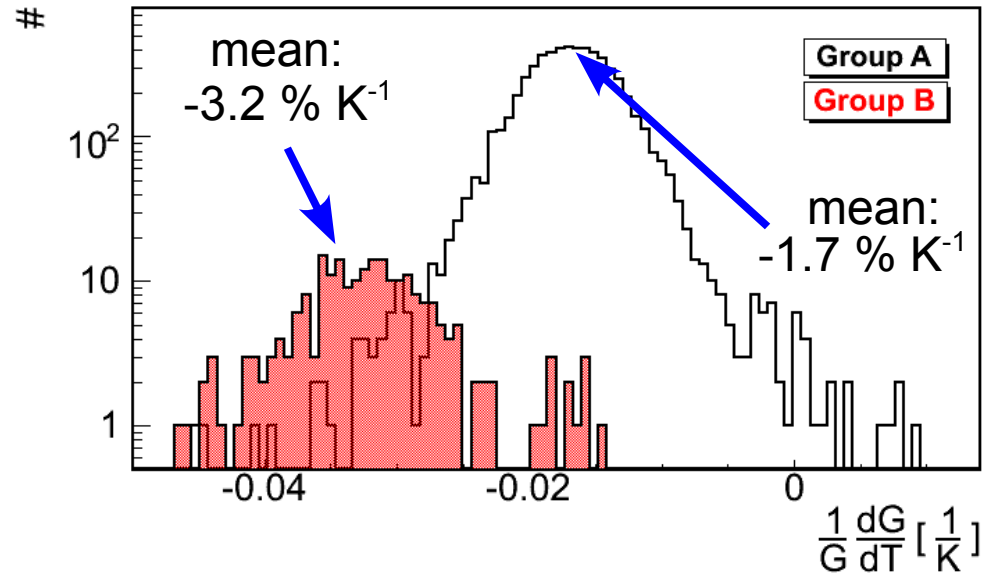
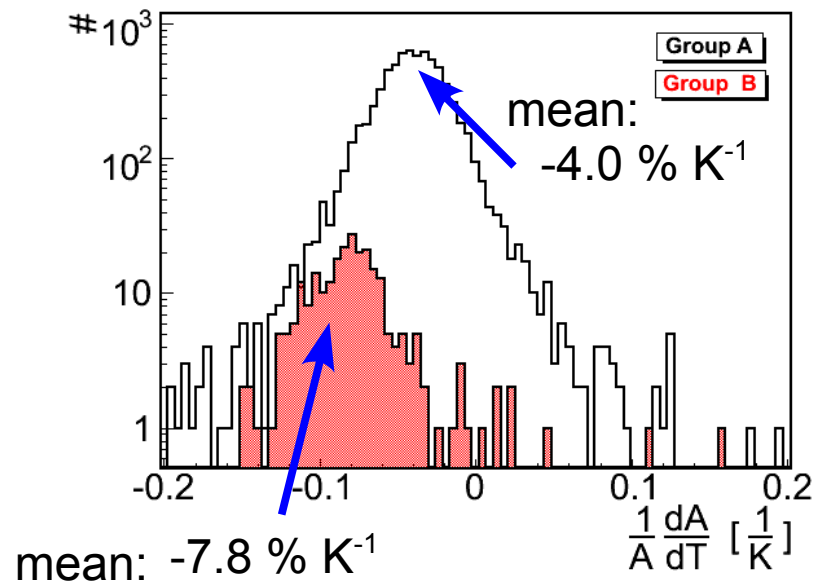


Figures by S.Uozumi

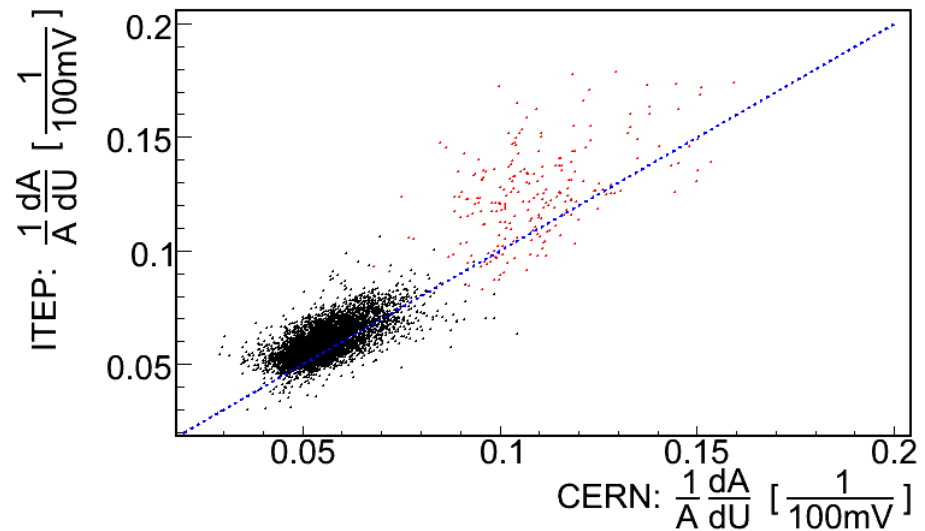
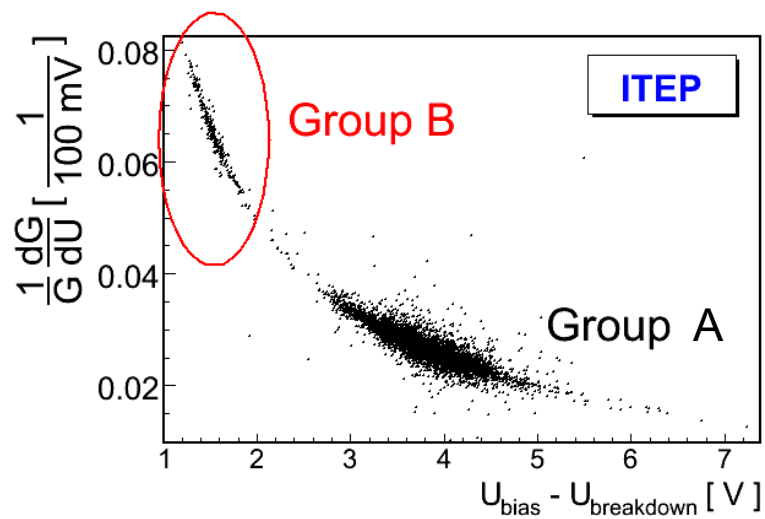
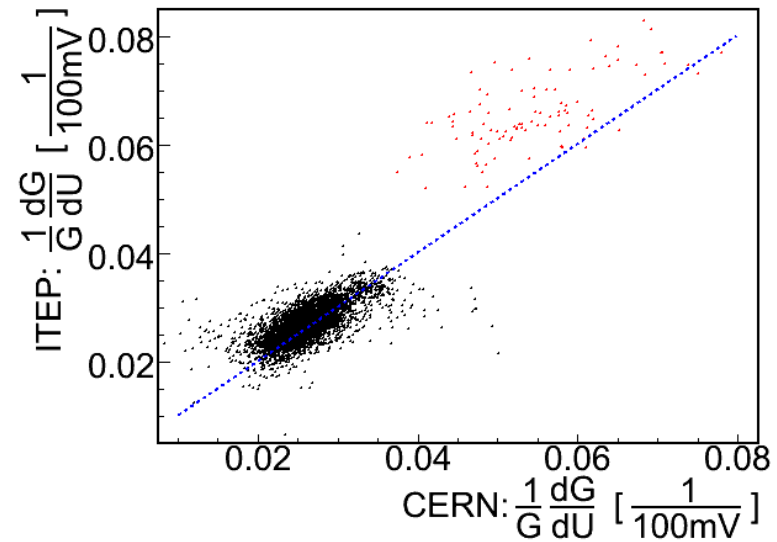
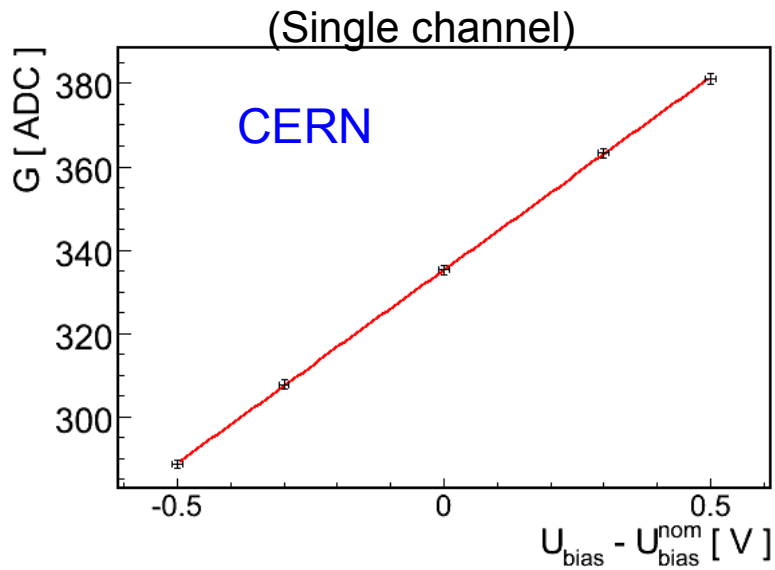
Temperature Dependence (CERN)



Plots: N. Feege



Voltage Dependencies: ITEP vs. CERN

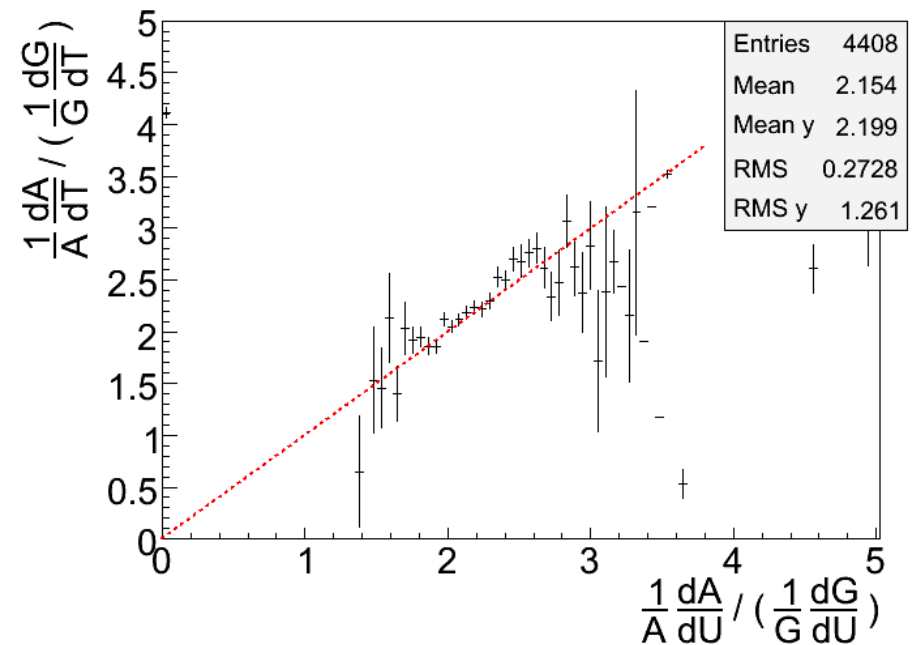
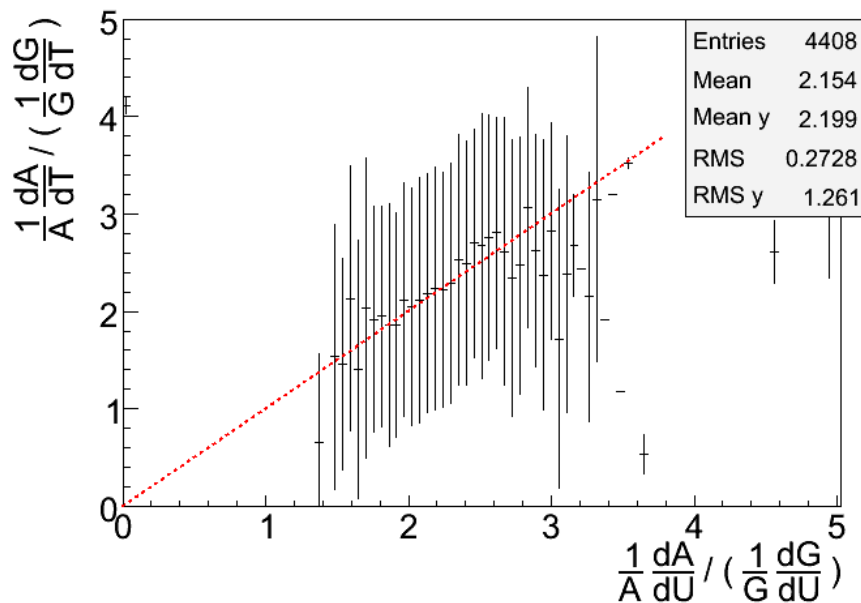


Plots: N. Feege

Relation of the Dependencies

- From $\frac{dG}{dT} = \frac{dG}{dU} \cdot \frac{dU}{dT}$ and $\frac{dA}{dT} = \frac{dA}{dU} \cdot \frac{dU}{dT}$ follows: $\frac{dA/dT}{dG/dT} = \frac{dA/dU}{dG/dU}$
- Testing this hypothesis:

Plots: N. Feege



Correction Methods

Method 1:
$$A = A_0 \cdot \left[1 + \frac{1}{A_0} \frac{dA}{dT} (T - T_0) \right] \quad G = G_0 \cdot \left[1 + \frac{1}{G_0} \frac{dG}{dT} (T - T_0) \right]$$

- Instantaneous: temperature measured frequently during data taking
- Non-local: only 5 temperature sensors per module

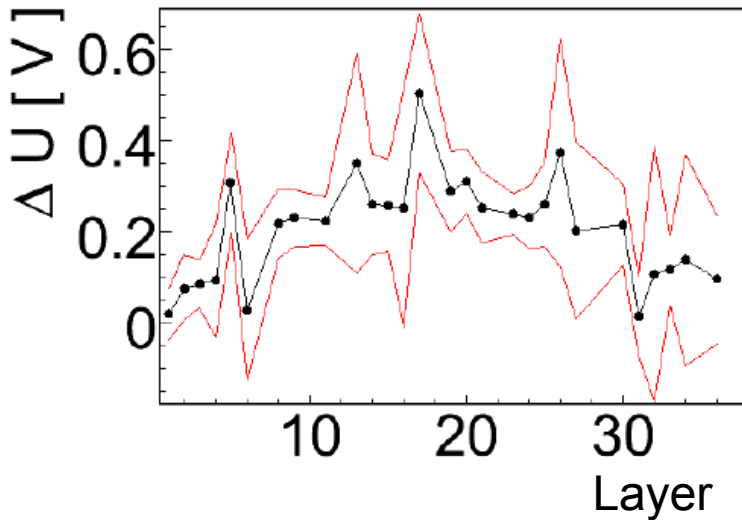
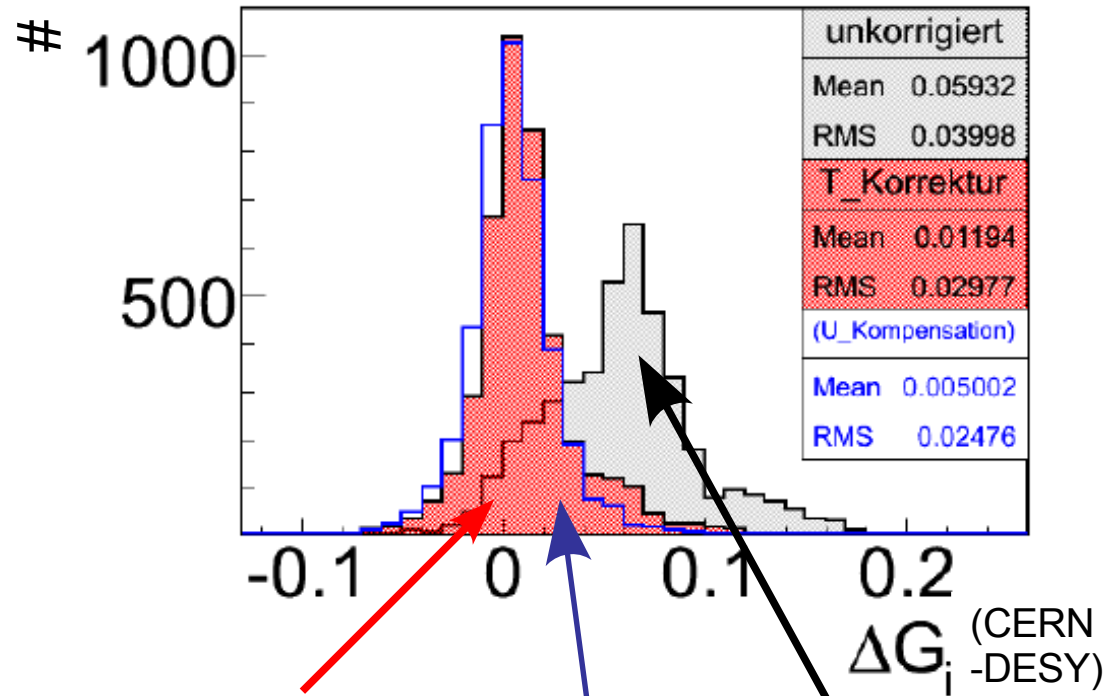
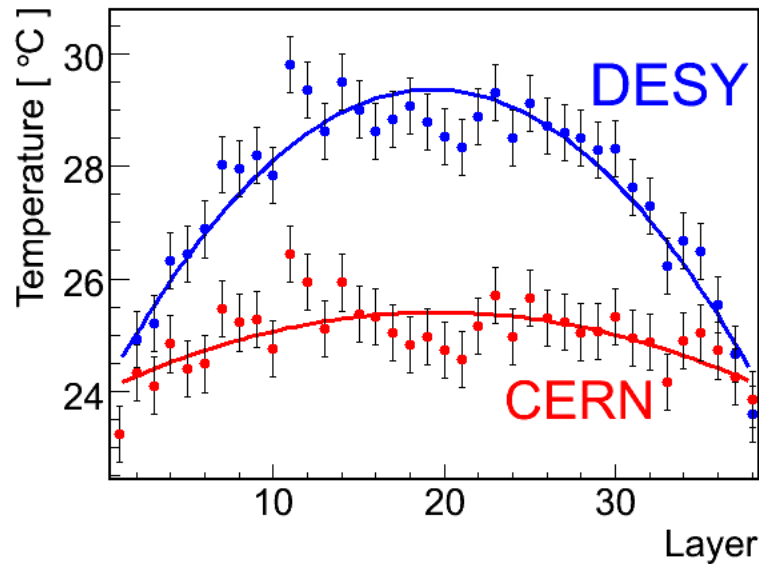
Method 2:
$$A = A_0 \cdot \left[1 + \frac{1}{A_0} \frac{dA}{dU} / \left(\frac{1}{G_0} \frac{dG}{dU} \right) \cdot (G - G_0) \right]$$

- Local: gain measured for every channel.
- Not instantaneous: gain measured few times per day in dedicated runs

Voltage Adjustment:
$$U = U_0 + (G - G_0) / \frac{dG}{dU}$$

- can not be performed daily or weekly, long time adjustment
- more radical, but most effective

Equalizing G by Voltage Adjustment



Required bias adjustment from observed gain shift (average per layer)

Temperature corrected (method 1)

Voltage-corrected (prediction)

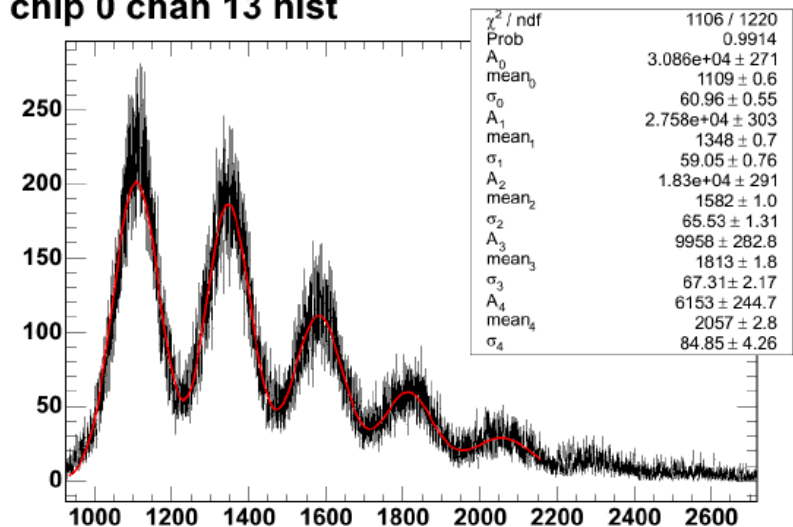
observed

Plots: N. Feege

Auto Calibration

- Each SiPM provides its own reference scale: the single pixel spectrum
- Promising tool to monitor response variations induced by temperature
- Possibilities for further simplification of calorimeter design:
 - No external reference
 - Small amplitudes
 - Loose stability requirements
- Stability of saturation correction:
 - Currently under study

FE 0 chip 0 chan 13 hist



Summary

- Calibration 2006 / 2007:
 - Dead channels
 - Saturation
 - MIP (detection eff. & SNR)
 - Light Yield
 - Gain calibration efficiency
- Temperature and Voltage Dependencies:
 - determination, relations, correction methods
- The SiPM provides auto calibration...